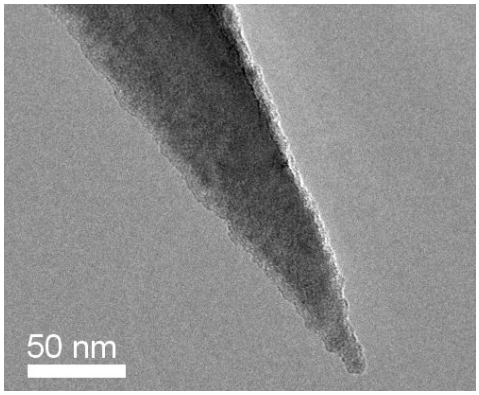
NANOSENSORS™
The World Leader in Scanning Probes

Improved Consistency and Resolution through an Advanced Tip Manufacturing Process

NANOSENSORS™ announces the new PointProbe® Plus AFM Probe

Neuchâtel, August 1st, 2004 –
NANOSENSORS™ today announced its new product, the PointProbe® Plus that will be replacing the Pointprobe-Silicon-SPM-Sensor. The new **P**oint**P**robe® **P**lus (PPP) AFM probe combines the well-known features of the proven PointProbe® Series such as high application versatility and compatibility with most commercial AFMs with a further reduced and more reproducible tip radius as well as a more defined tip shape. The typical tip radius of less than 7 nm and the minimized variation in tip shape provide more reproducible images and enhanced resolution.



TEM image of the PointProbe® Plus tip apex

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